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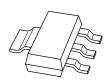
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PBSS302NZ 20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor Rev. 02 — 20 November 2009

Product data sheet

### **Product profile** 1.

### 1.1 General description

NPN low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a SOT223 (SC-73) small Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS302PZ.

### **1.2 Features**

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (h<sub>FE</sub>) at high I<sub>C</sub>
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

# 1.3 Applications

- DC-to-DC conversion
- MOSFET gate driving
- Motor control
- Charging circuits
- Power switches (e.g. motors, fans)

# 1.4 Quick reference data

### Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	20	V
I <sub>C</sub>	collector current		-	-	5.8	А
I <sub>CM</sub>	peak collector current	single pulse; t <sub>p</sub> ≤ 1 ms	-	-	11.6	A
R <sub>CEsat</sub>	collector-emitter saturation resistance	I <sub>C</sub> = 4 A; I <sub>B</sub> = 200 mA	<u>[1]</u> _	30	43	mΩ

[1] Pulse test:  $t_p \le 300 \ \mu s$ ;  $\delta \le 0.02$ .



20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

# 2. Pinning information

Description	Simplified outline	Symbol		
base		-		
collector		2, 4		
emitter		1		
collector		3		
	collector emitter	collector 4 emitter 1 collector 1		

# 3. Ordering information

Table 3. Ordering information						
Type number	Package					
	Name	Description	Version			
PBSS302NZ	SC-73	plastic surface-mounted package with increased heat sink; 4 leads	SOT223			

# 4. Marking

Table 4.         Marking codes	
Type number	Marking code
PBSS302NZ	S302NZ

20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

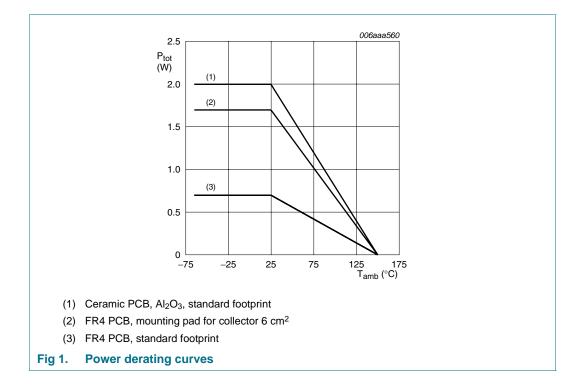
# 5. Limiting values

Table 5.Limiting valuesIn accordance with the Absolute Maximum Rating System (IEC 60134).					
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CBO</sub>	collector-base voltage	open emitter	-	20	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	20	V
V <sub>EBO</sub>	emitter-base voltage	open collector	-	5	V
I <sub>C</sub>	collector current		-	5.8	А
I <sub>CM</sub>	peak collector current	single pulse; $t_p \leq 1 ms$	-	11.6	A
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$	<u>[1]</u> -	0.7	W
			[2] _	1.7	W
			[3] _	2	W
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

[3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

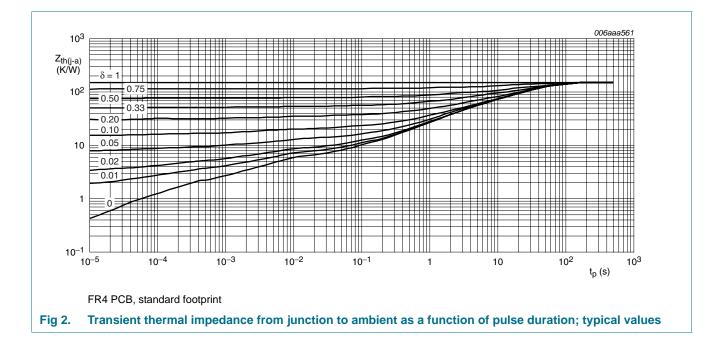
# 6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	-	179	K/W
			[2] _	-	74	K/W
			[3]	-	63	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		-	-	15	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

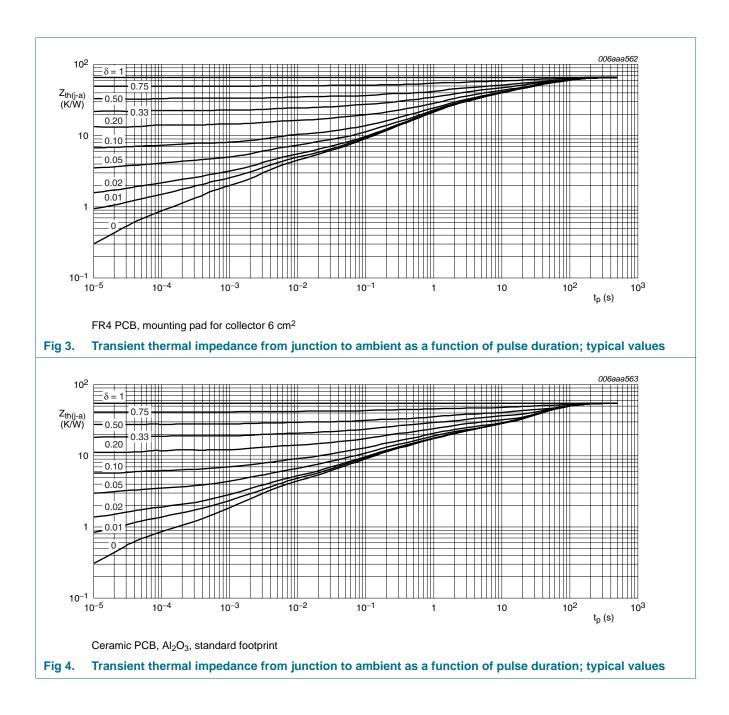
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

[3] Device mounted on a ceramic PCB,  $AI_2O_3$ , standard footprint.



# PBSS302NZ

### 20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor



20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

# 7. Characteristics

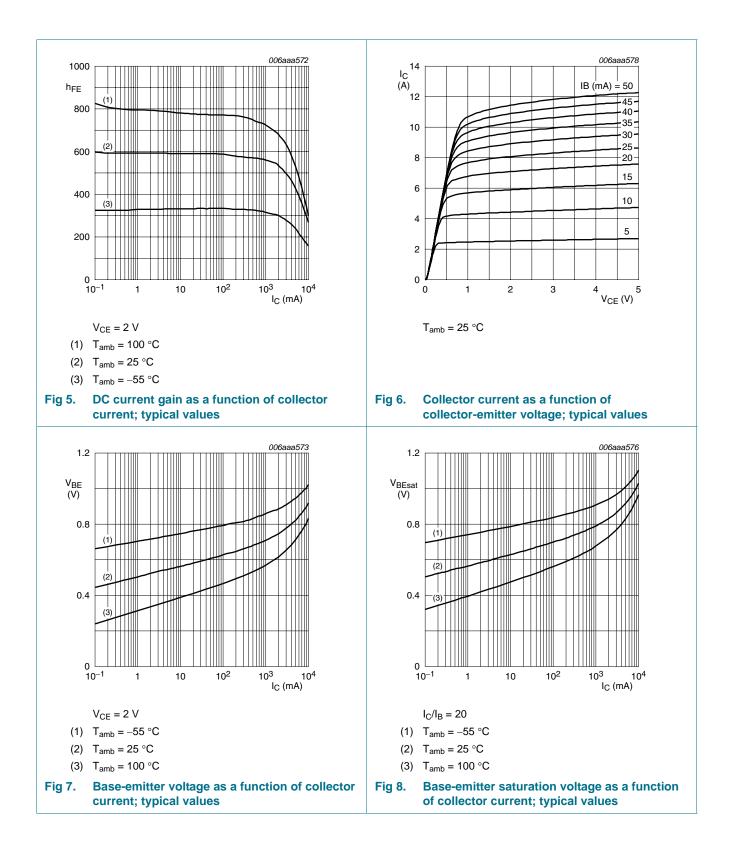
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
	collector-base cut-off current	$V_{CB} = 20 \text{ V}; I_E = 0 \text{ A}$		-	-	100	nA
		$\label{eq:VCB} \begin{array}{l} V_{CB} = 20 \text{ V}; \text{ I}_{E} = 0 \text{ A}; \\ T_{j} = 150 \ ^{\circ}\text{C} \end{array}$		-	-	50	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 V; I_{C} = 0 A$		-	-	100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = 2 \text{ V}; I_{C} = 0.5 \text{ A}$	[1]	300	570	-	
		$V_{CE} = 2 \text{ V}; \text{ I}_{C} = 1 \text{ A}$	[1]	300	550	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	[1]	250	520	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 4 \text{ A}$	[1]	200	450	-	
		$V_{CE} = 2 \text{ V}; \text{ I}_{C} = 7 \text{ A}$	<u>[1]</u>	200	350	-	
V <sub>CEsat</sub>	collector-emitter	$I_{C} = 0.5 \text{ A}; I_{B} = 50 \text{ mA}$	[1]	-	20	25	mV
	saturation voltage	I <sub>C</sub> = 1 A; I <sub>B</sub> = 50 mA	[1]	-	35	50	mV
		I <sub>C</sub> = 1 A; I <sub>B</sub> = 10 mA	[1]	-	50	70	mV
		$I_{C} = 2 \text{ A}; I_{B} = 40 \text{ mA}$	[1]	-	70	100	mV
		I <sub>C</sub> = 4 A; I <sub>B</sub> = 200 mA	[1]	-	120	170	mV
		I <sub>C</sub> = 4 A; I <sub>B</sub> = 400 mA	[1]	-	115	165	mV
		$I_{C} = 4 \text{ A}; I_{B} = 40 \text{ mA}$	[1]	-	155	240	mV
		$I_{C} = 5.8 \text{ A}; I_{B} = 290 \text{ mA}$	[1]	-	170	250	mV
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_{C} = 4 \text{ A}; I_{B} = 200 \text{ mA}$	[1]	-	30	43	mΩ
		$I_{C} = 4 \text{ A}; I_{B} = 40 \text{ mA}$	[1]	-	38	60	mΩ
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_{C} = 1 \text{ A}; I_{B} = 100 \text{ mA}$	[1]	-	0.82	0.9	V
		$I_{C} = 4 \text{ A}; I_{B} = 400 \text{ mA}$	[1]	-	0.92	1.05	V
V <sub>BEon</sub>	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; \text{ I}_{C} = 2 \text{ A}$	<u>[1]</u>	-	0.75	0.85	V
d	delay time	$V_{CC} = 12.5 \text{ V}; I_{C} = 3 \text{ A};$		-	15	-	ns
t <sub>r</sub>	rise time	I <sub>Bon</sub> = 0.15 A; - I <sub>Boff</sub> = −0.15 A		-	40	-	ns
on	turn-on time	BOIL0.12 V		-	55	-	ns
t <sub>s</sub>	storage time			-	270	-	ns
f	fall time			-	85	-	ns
off	turn-off time			-	355	-	ns
T	transition frequency	$V_{CE} = 10 \text{ V}; I_{C} = 100 \text{ mA};$ f = 100 MHz		-	140	-	MHz
Cc	collector capacitance	$V_{CB} = 10 \text{ V}; \text{ I}_{E} = \text{i}_{e} = 0 \text{ A};$ f = 1 MHz		-	95	150	рF

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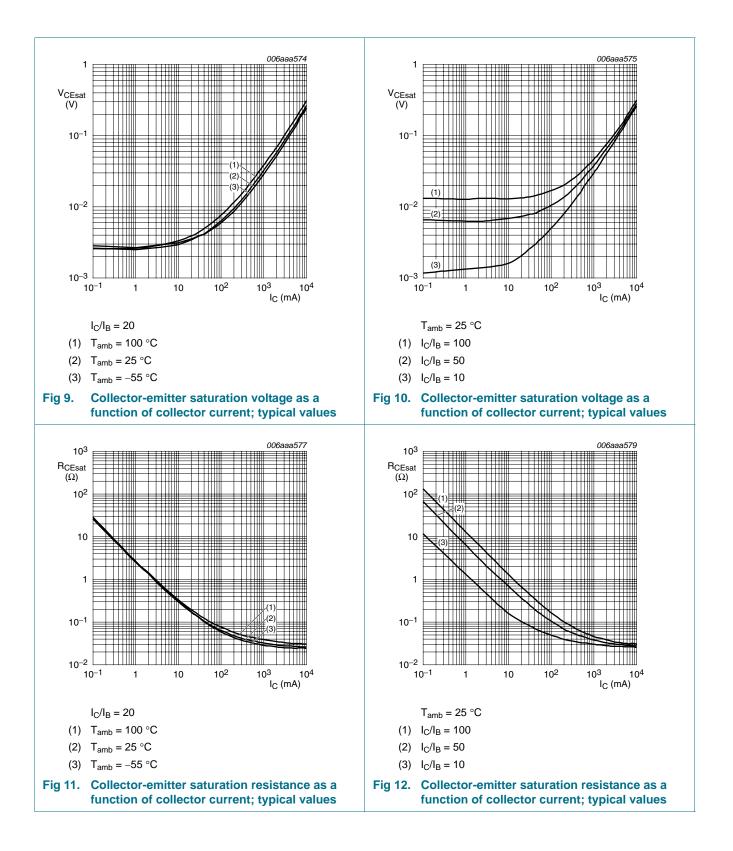
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### 20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor



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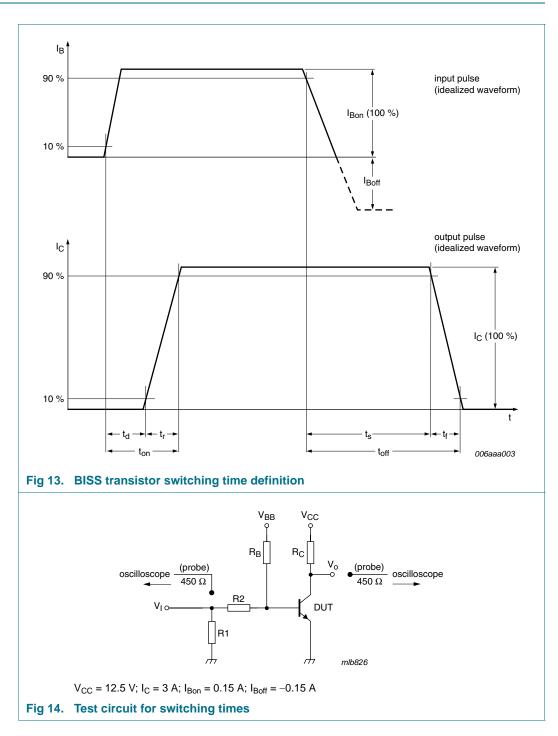
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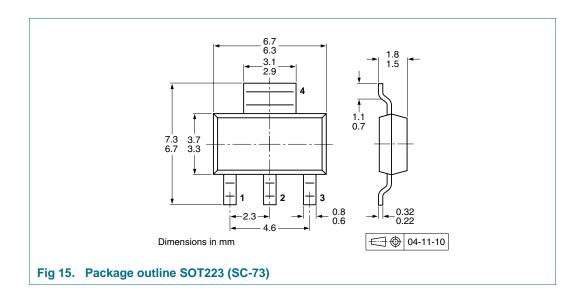
20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

# 8. Test information



20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

# 9. Package outline



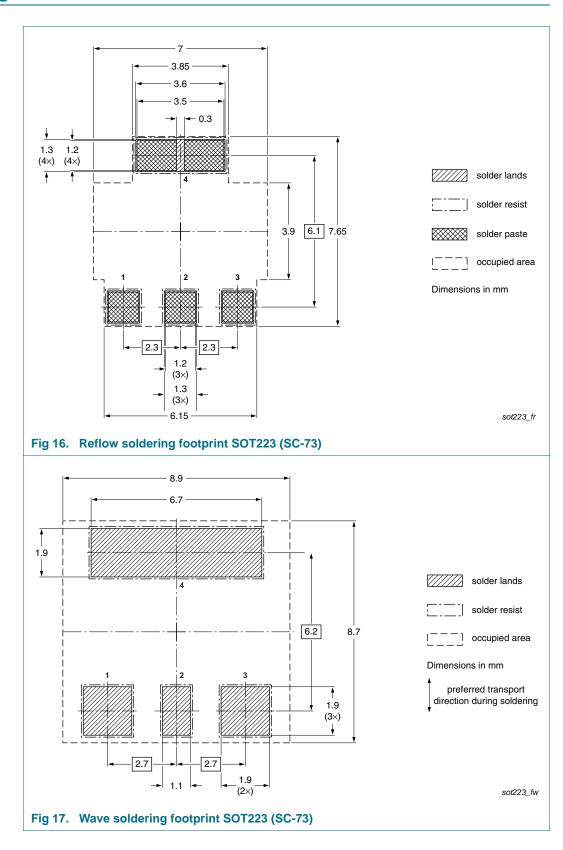
# **10. Packing information**

# Table 8. Packing methodsThe indicated -xxx are the last three digits of the 12NC ordering code.[1]Type numberPackageDescriptionPacking quantity10004000PBSS302NZSOT2238 mm pitch, 12 mm tape and reel-115-135

[1] For further information and the availability of packing methods, see <u>Section 14</u>.

20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

# 11. Soldering





20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

# **12. Revision history**

Table 9. Revision his	story					
Document ID	Release date	Data sheet status	Change notice	Supersedes		
PBSS302NZ_2	20091120	Product data sheet	-	PBSS302NZ_1		
Modifications:		neet was changed to reflect w legal definitions and dis				
	<ul> <li>Figure 16 "Reflow soldering footprint SOT223 (SC-73)": updated</li> </ul>					
	<ul> <li>Figure 17 "V</li> </ul>	Vave soldering footprint So	<u> </u>	l		
PBSS302NZ_1	20060908	Product data sheet	-	-		

20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

# 13. Legal information

### Data sheet status 13.1

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

The term 'short data sheet' is explained in section "Definitions". [2]

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://w

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PBSS302NZ 2

# PBSS302NZ

20 V, 5.8 A NPN low V<sub>CEsat</sub> (BISS) transistor

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